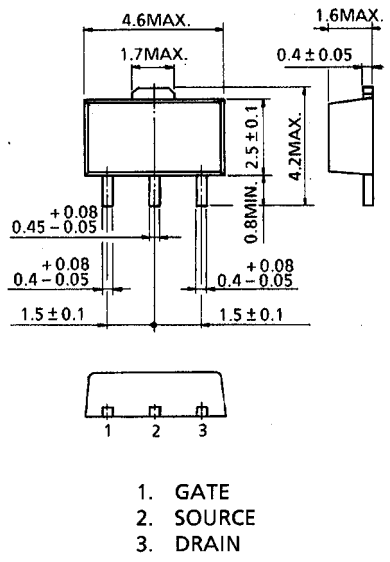
TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE

2SK3078

900 MHz BAND AMPLIFIER APPLICATIONS (GSM)

- Output Power : P_O = 27.0 dBmW (Min.)
- Gain : G_P = 12.5 dB (Min.)
- Drain Efficiency : η_D = 46% (Typ.)

Unit: mm



1. GATE
2. SOURCE
3. DRAIN

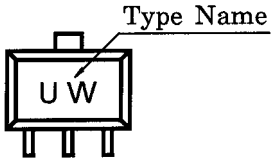
JEDEC	—
JEITA	SC−62
TOSHIBA	2−5K1D

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	V_{DSS}	10	V
Gate-Source Voltage	V_{GSS}	5	V
Drain Current	I_D	0.5	A
Power Dissipation	P_{D*}	3.0	W
Channel Temperature	T_{ch}	150	°C
Storage Temperature Range	T_{stg}	−45~150	°C

*: Tc = 25°C When mounted on a 1.6 mm glass epoxy PCB

MARKING



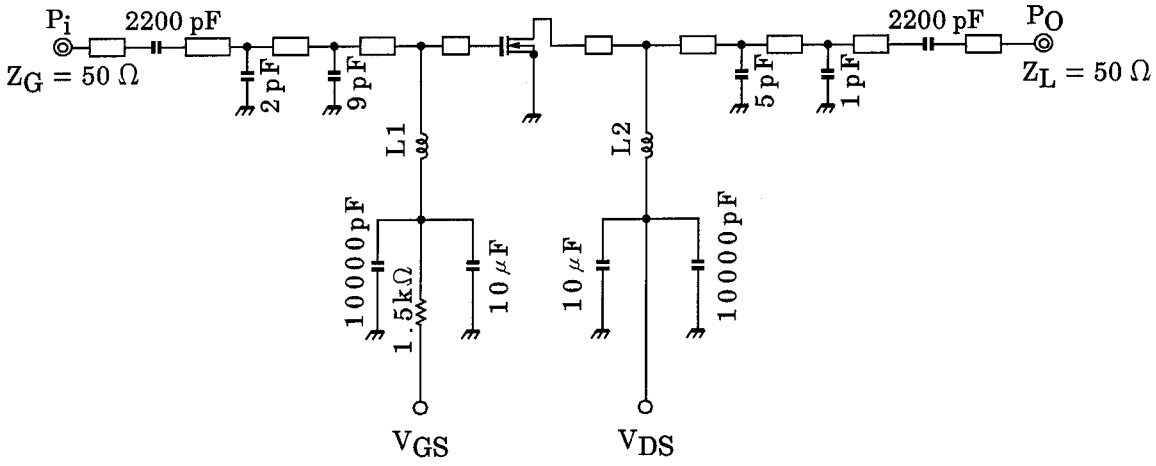
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Output Power	P_O	V_{DS} = 4.8 V Iidle = 108 mA (V_{GS} = adjust) f = 915 MHz, P_i = 14.5 dBmW	27.0	—	—	dBmW
Drain Efficiency	η_D		—	46.0	—	%
Power Gain	G_P		12.5	—	—	dB
Threshold Voltage	V_{th}	V_{DS} = 4.8 V, I_D = 0.5 mA	0.20	—	1.20	V
Drain Cut-off Current	I_{DSS}	V_{DS} = 10 V, V_{GS} = 0 V	—	—	10	μA
Gate-Source Leakage Current	I_{GSS}	V_{GS} = 5 V, V_{DS} = 0 V	—	—	5	μA

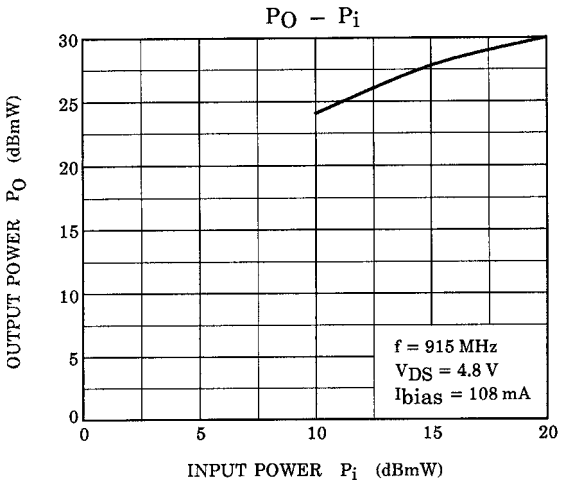
CAUTION

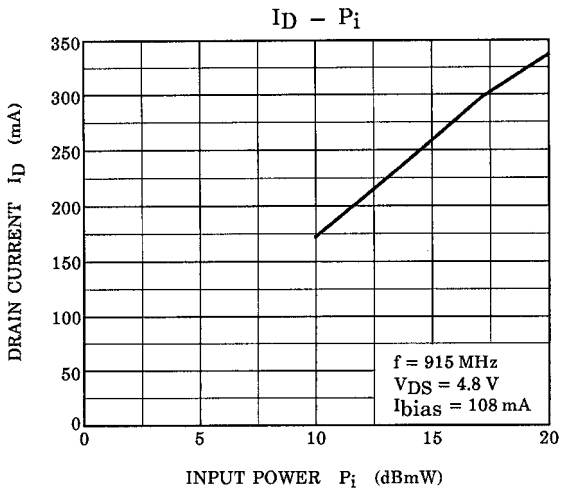
This transistor is the electrostatic sensitive device.
Please handle with caution.

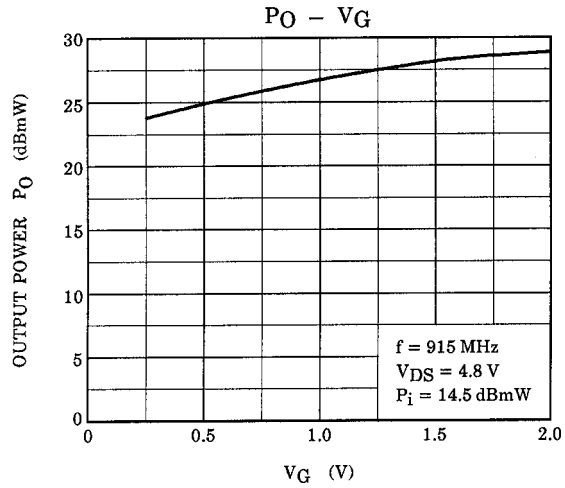
RF OUTPUT POWER TEST FIXTURE

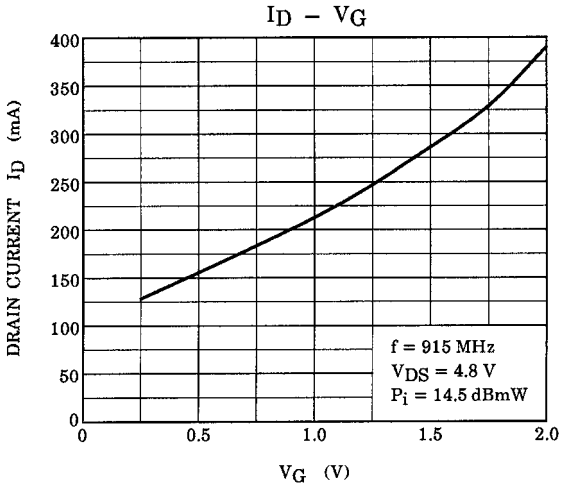


L1 : ϕ0.6 mm, 5.5 mmID, 4T
L2 : ϕ0.6 mm, 5.5 mmID, 8T









CAUTION

These are only typical curves and devices are not necessarily guaranteed at these curves.

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000707EAA

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